

Designer's™ Data Sheet

Insulated Gate Bipolar Transistor with Anti-Parallel Diode

N-Channel Enhancement-Mode Silicon Gate

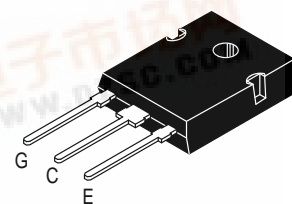
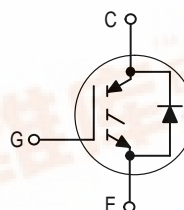
MGW12N120D

Motorola Preferred Device

IGBT & DIODE IN TO-247
 12 A @ 90°C
 20 A @ 25°C
 1200 VOLTS
 SHORT CIRCUIT RATED

This Insulated Gate Bipolar Transistor (IGBT) is co-packaged with a soft recovery ultra-fast rectifier and uses an advanced termination scheme to provide an enhanced and reliable high voltage-blocking capability. Short circuit rated IGBT's are specifically suited for applications requiring a guaranteed short circuit withstand time such as Motor Control Drives. Fast switching characteristics result in efficient operation at high frequencies. Co-packaged IGBT's save space, reduce assembly time and cost.

- Industry Standard High Power TO-247 Package with Isolated Mounting Hole
- High Speed E_{off} : 160 μ s per Amp typical at 125°C
- High Short Circuit Capability – 10 μ s minimum
- Soft Recovery Free Wheeling Diode is included in the package
- Robust High Voltage Termination
- Robust RBSOA



CASE 340F-03, Style 4
TO-247AE

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CES}	1200	Vdc
Collector-Gate Voltage ($R_{GE} = 1.0 \text{ M}\Omega$)	V_{CGR}	1200	Vdc
Gate-Emitter Voltage — Continuous	V_{GE}	± 20	Vdc
Collector Current — Continuous @ $T_C = 25^\circ\text{C}$	I_{C25}	20	Adc
— Continuous @ $T_C = 90^\circ\text{C}$	I_{C90}	12	
— Repetitive Pulsed Current (1)	I_{CM}	40	Apk
Total Power Dissipation @ $T_C = 25^\circ\text{C}$	P_D	123	Watts
Derate above 25°C		0.98	W/°C
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-55 to 150	°C
Short Circuit Withstand Time ($V_{CC} = 720 \text{ Vdc}, V_{GE} = 15 \text{ Vdc}, T_J = 125^\circ\text{C}, R_G = 20 \Omega$)	t_{sc}	10	μ s
Thermal Resistance — Junction to Case – IGBT	$R_{\theta JC}$	1.0	°C/W
— Junction to Case – Diode	$R_{\theta JC}$	1.4	
— Junction to Ambient	$R_{\theta JA}$	45	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T_L	260	°C
Mounting Torque, 6-32 or M3 screw		10 lbf•in (1.13 N•m)	

(1) Pulse width is limited by maximum junction temperature. Repetitive rating.

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

Preferred devices are Motorola recommended choices for future use and best overall value.



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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Collector-to-Emitter Breakdown Voltage (V _{GE} = 0 Vdc, I _C = 25 μAdc) Temperature Coefficient (Positive)	BV _{CES}	1200 —	— 870	— —	Vdc mV/°C
Zero Gate Voltage Collector Current (V _{CE} = 1200 Vdc, V _{GE} = 0 Vdc) (V _{CE} = 1200 Vdc, V _{GE} = 0 Vdc, T _J = 125°C)	I _{CES}	— —	— —	100 2500	μAdc
Gate-Body Leakage Current (V _{GE} = ± 20 Vdc, V _{CE} = 0 Vdc)	I _{GES}	—	—	250	nAdc

ON CHARACTERISTICS (1)

Collector-to-Emitter On-State Voltage (V _{GE} = 15 Vdc, I _C = 5.0 Adc) (V _{GE} = 15 Vdc, I _C = 5.0 Adc, T _J = 125°C) (V _{GE} = 15 Vdc, I _C = 10 Adc)	V _{CE(on)}	— — —	2.71 3.78 3.72	3.37 — 4.42	Vdc
Gate Threshold Voltage (V _{CE} = V _{GE} , I _C = 1.0 mAdc) Threshold Temperature Coefficient (Negative)	V _{GE(th)}	4.0 —	6.0 10	8.0 —	Vdc mV/°C
Forward Transconductance (V _{CE} = 10 Vdc, I _C = 10 Adc)	g _{fe}	—	12	—	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{CE} = 25 Vdc, V _{GE} = 0 Vdc, f = 1.0 MHz)	C _{ies}	—	1003	—	pF
Output Capacitance		C _{oes}	—	126	—	
Transfer Capacitance		C _{res}	—	106	—	

SWITCHING CHARACTERISTICS (1)

Turn-On Delay Time	(V _{CC} = 720 Vdc, I _C = 10 Adc, V _{GE} = 15 Vdc, L = 300 μH R _G = 20 Ω, T _J = 25°C) Energy losses include "tail"	t _{d(on)}	—	74	—	ns
Rise Time		t _r	—	83	—	
Turn-Off Delay Time		t _{d(off)}	—	76	—	
Fall Time		t _f	—	231	—	mJ
Turn-Off Switching Loss		E _{off}	—	0.55	1.33	
Turn-On Switching Loss		E _{on}	—	1.21	1.88	
Total Switching Loss		E _{ts}	—	1.76	3.21	
Turn-On Delay Time	(V _{CC} = 720 Vdc, I _C = 10 Adc, V _{GE} = 15 Vdc, L = 300 μH R _G = 20 Ω, T _J = 125°C) Energy losses include "tail"	t _{d(on)}	—	66	—	ns
Rise Time		t _r	—	87	—	
Turn-Off Delay Time		t _{d(off)}	—	120	—	
Fall Time		t _f	—	575	—	mJ
Turn-Off Switching Loss		E _{off}	—	1.49	—	
Turn-On Switching Loss		E _{on}	—	2.37	—	
Total Switching Loss		E _{ts}	—	3.86	—	
Gate Charge	(V _{CC} = 720 Vdc, I _C = 10 Adc, V _{GE} = 15 Vdc)	Q _T	—	29	—	nC
		Q ₁	—	13	—	
		Q ₂	—	12	—	

DIODE CHARACTERISTICS

Diode Forward Voltage Drop (I _{EC} = 5.0 Adc) (I _{EC} = 5.0 Adc, T _J = 125°C) (I _{EC} = 10 Adc)	V _{FEC}	— — —	2.26 1.37 2.86	3.32 — 4.18	Vdc
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(1) Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

(continued)

ELECTRICAL CHARACTERISTICS — continued ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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DIODE CHARACTERISTICS — continued

Reverse Recovery Time	$(I_F = 10 \text{ Adc}, V_R = 720 \text{ Vdc}, dI_F/dt = 100 \text{ A}/\mu\text{s})$	t_{rr}	—	116	—	ns
		t_a	—	69	—	
		t_b	—	47	—	
Reverse Recovery Stored Charge		Q_{RR}	—	0.36	—	μC
Reverse Recovery Time	$(I_F = 10 \text{ Adc}, V_R = 720 \text{ Vdc}, dI_F/dt = 100 \text{ A}/\mu\text{s}, T_J = 125^\circ\text{C})$	t_{rr}	—	234	—	ns
		t_a	—	149	—	
		t_b	—	85	—	
Reverse Recovery Stored Charge		Q_{RR}	—	1.40	—	μC

INTERNAL PACKAGE INDUCTANCE

Internal Emitter Inductance (Measured from the emitter lead 0.25" from package to emitter bond pad)	L_E	—	13	—	nH
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TYPICAL ELECTRICAL CHARACTERISTICS

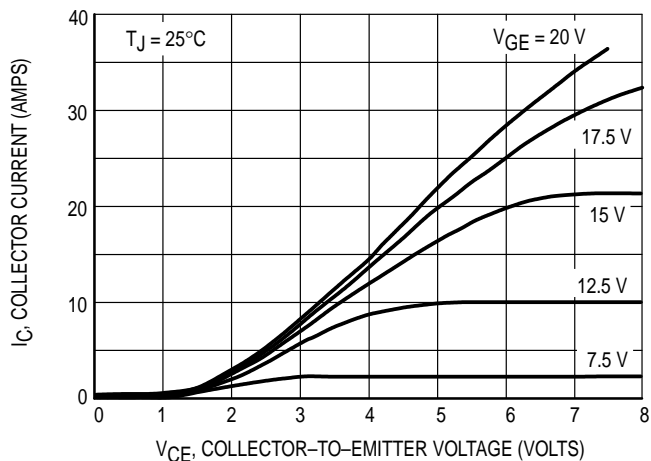


Figure 1. Output Characteristics, $T_J = 25^\circ\text{C}$

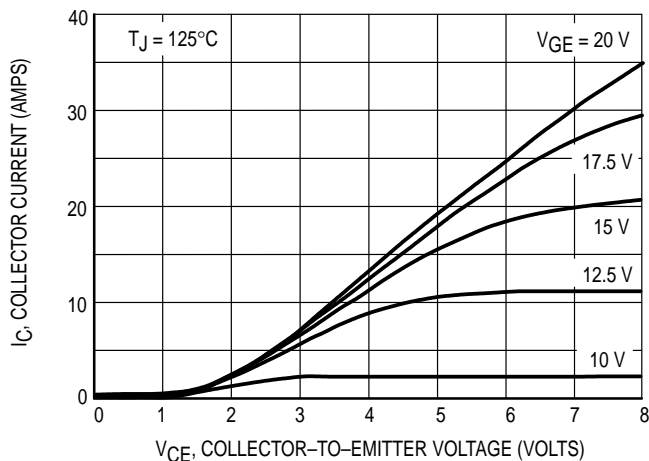


Figure 2. Output Characteristics, $T_J = 125^\circ\text{C}$

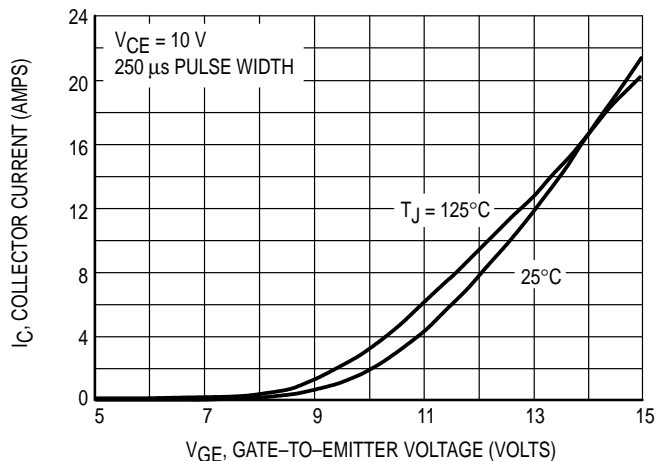


Figure 3. Transfer Characteristics

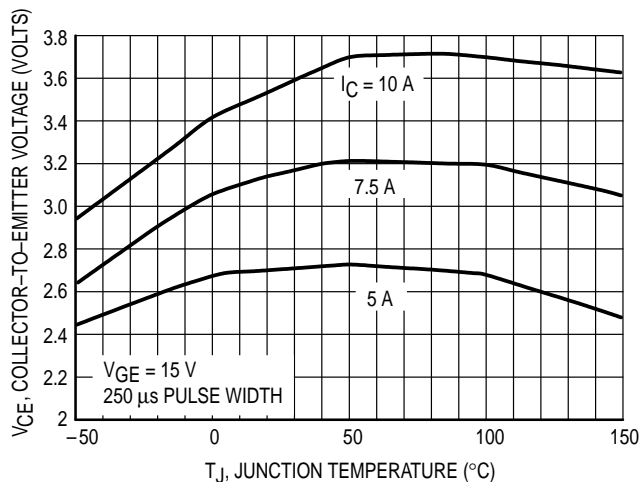


Figure 4. Collector-to-Emitter Saturation Voltage versus Junction Temperature

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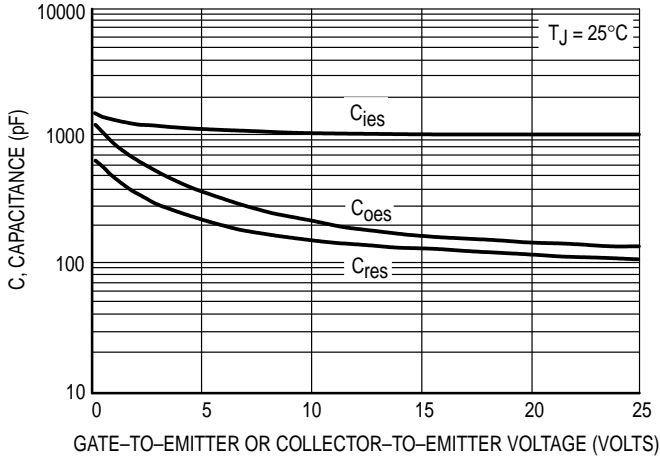


Figure 5. Capacitance Variation

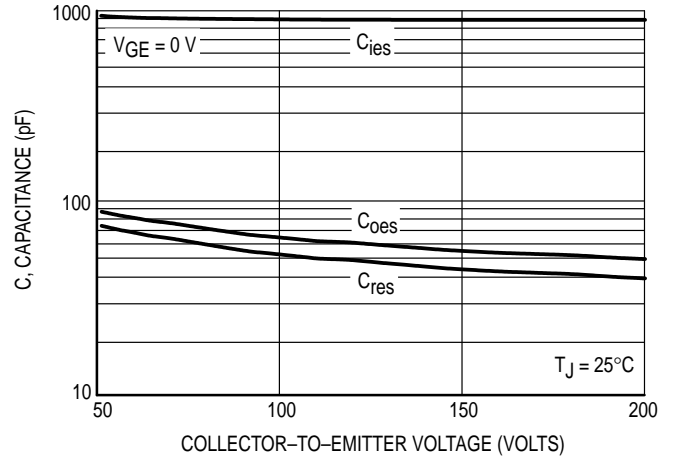


Figure 5b. High Voltage Capacitance Variation

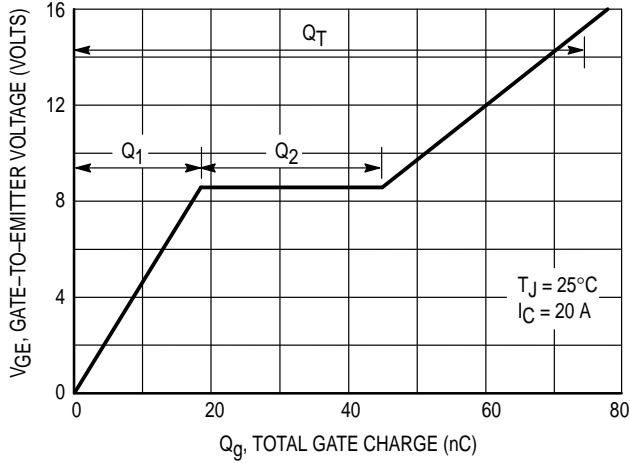


Figure 6. Gate-to-Emitter and Collector-to-Emitter Voltage versus Total Charge

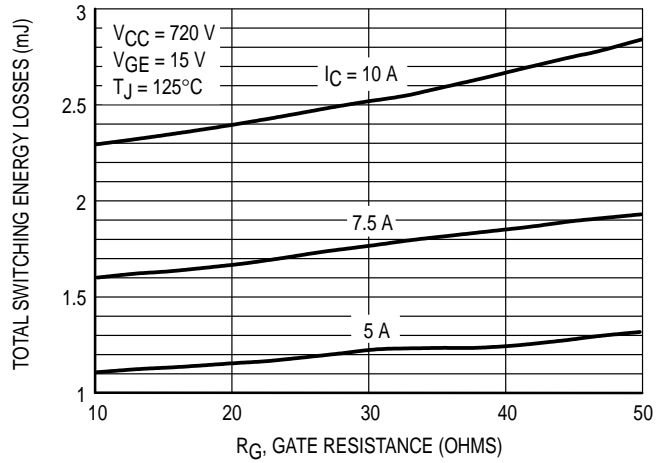


Figure 7. Total Switching Losses versus Gate Resistance

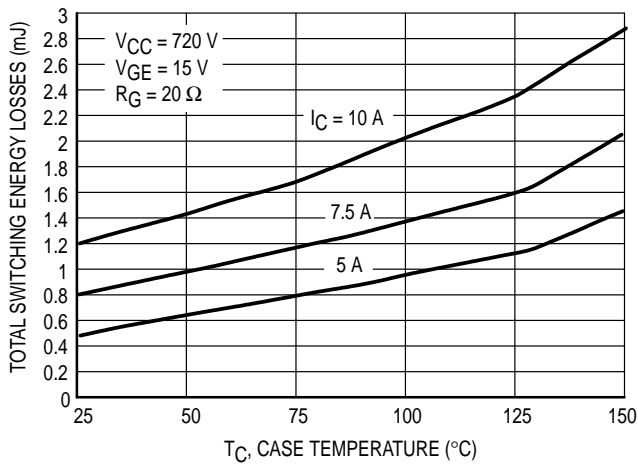


Figure 8. Total Switching Losses versus Case Temperature

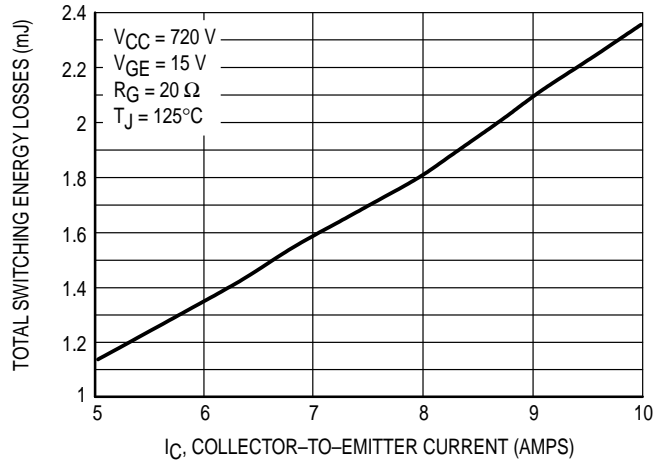


Figure 9. Total Switching Losses versus Collector-to-Emitter Current

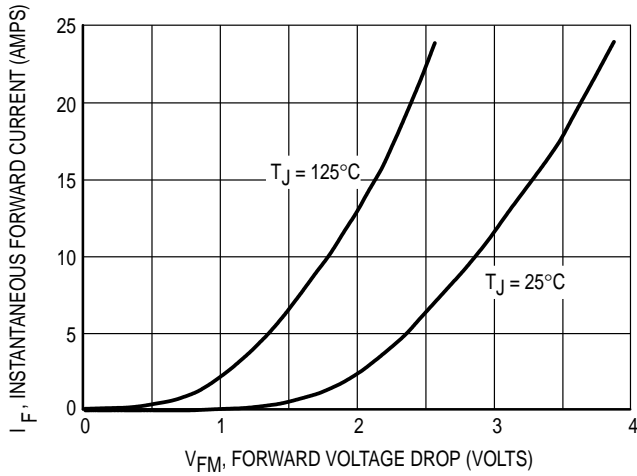


Figure 10. Maximum Forward Drop versus Instantaneous Forward Current

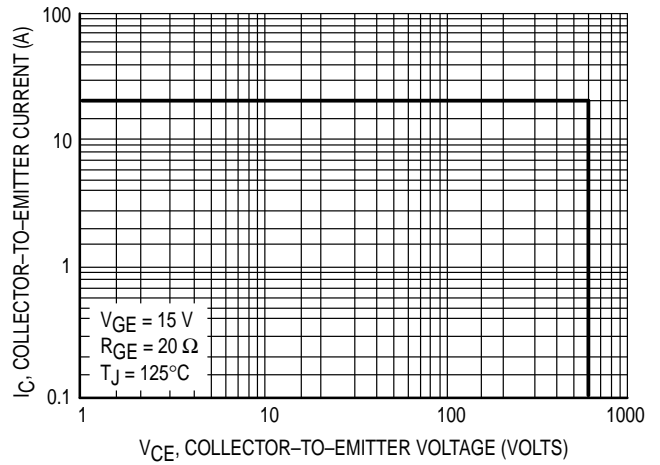


Figure 11. Reverse Biased Safe Operating Area

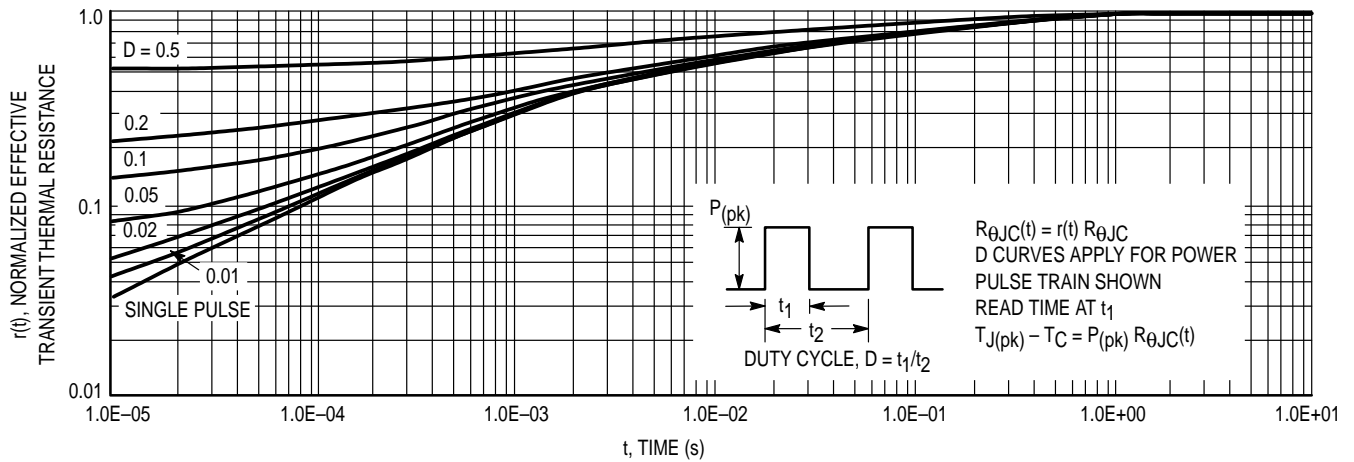
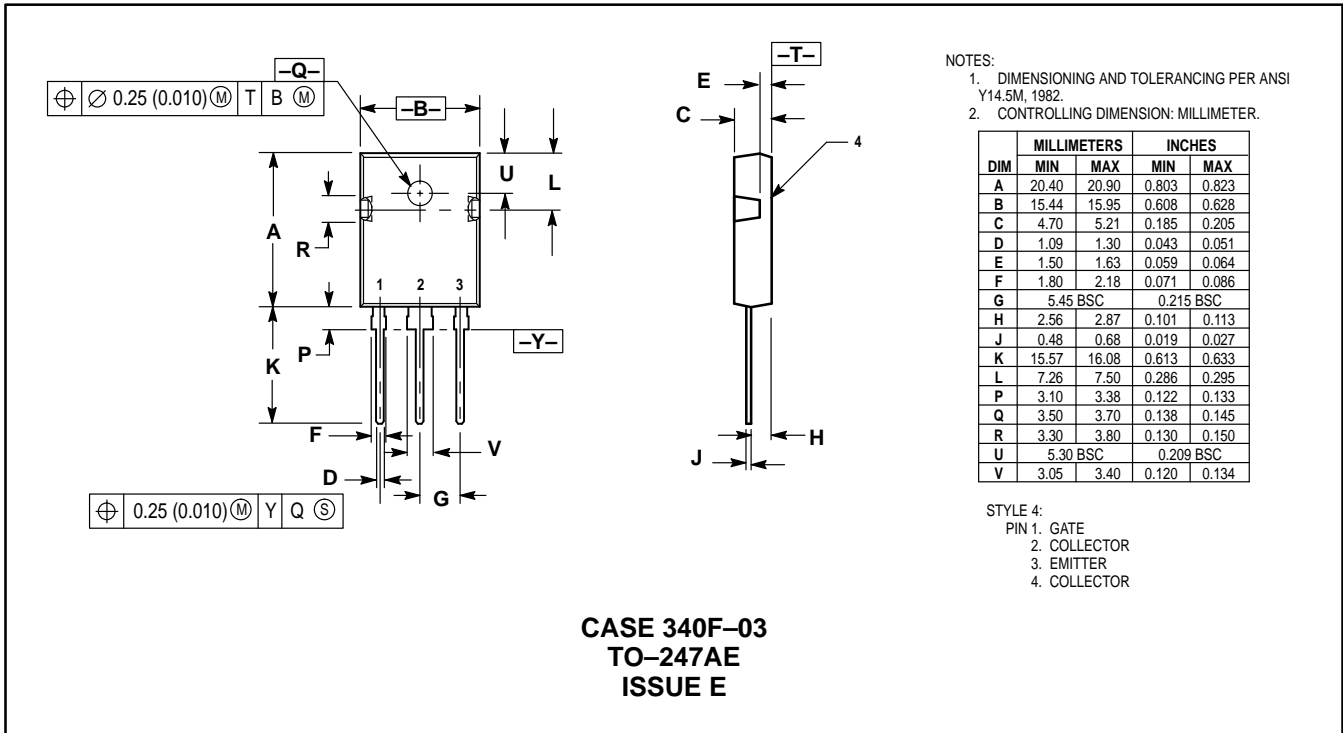


Figure 12. Thermal Response

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PACKAGE DIMENSIONS



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